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N-Channel Power MOSFET 620 V, 0.75 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	NDF10N62Z	Unit
Drain-to-Source Voltage	V_{DSS}	620	V
Continuous Drain Current, $R_{\theta JC}$ (Note 2)	I _D	10	Α
Continuous Drain Current $R_{\theta JC}$, $T_A = 100^{\circ}C$ (Note 2)	I _D	5.7	Α
Pulsed Drain Current, V _{GS} @ 10 V	I _{DM}	36	Α
Power Dissipation, $R_{\theta JC}$ (Note 1)	P_{D}	36	W
Gate-to-Source Voltage	V _{GS}	±30	V
Single Pulse Avalanche Energy, I _D = 10 A	E _{AS}	300	mJ
ESD (HBM) (JESD22-A114)	V _{esd}	3900	V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, $T_A = 25^{\circ}C$) (Figure 14)	V _{ISO}	4500	V
Peak Diode Recovery	dv/dt	4.5 (Note 3)	V/ns
Continuous Source Current (Body Diode)	I _S	10	Α
Maximum Temperature for Soldering Leads	TL	260	°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1

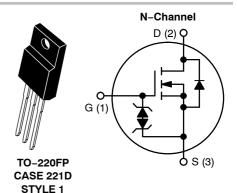
- Surface mounted on FR4 board using 1" sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces)
- 2. Limited by maximum junction temperature
- 3. $I_S \le 10 \text{ A}$, $di/dt \le 200 \text{ A}/\mu s$, $V_{DD} = 80\% \text{ BV}_{DSS}$



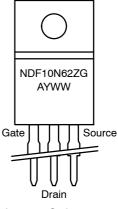
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V _{DSS}	R _{DS(ON)} (MAX) @ 5 A
620 V	0.75 Ω



MARKING DIAGRAM



A = Location Code

Y = Year WW = Work Week

G = Pb-Free, Halogen-Free Package

ORDERING INFORMATION

Device	Package	Shipping
NDF10N62ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units/Rail

THERMAL RESISTANCE

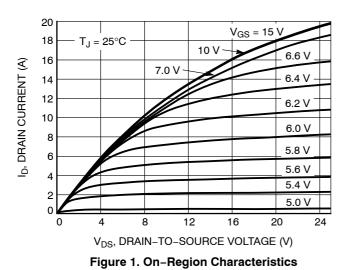
Parameter	Symbol	NDF10N62Z	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.4	°C/W
Junction-to-Ambient Steady State (Note 4)	$R_{\theta JA}$	50	

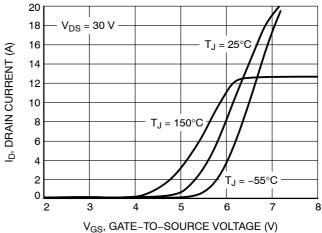
FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	•	
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA}$		BV _{DSS}	620			V
Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D = 1 mA		$\Delta BV_{DSS}/ \Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	V _{DS} = 620 V, V _{GS} = 0 V	25°C 125°C	I _{DSS}			1 50	μΑ
Gate-to-Source Forward Leakage	V _{GS} = ±20 V		I _{GSS}			±10	μΑ
ON CHARACTERISTICS (Note 5)					•		•
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 5.0 \text{ A}$	4	R _{DS(on)}		0.65	0.75	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$		V _{GS(th)}	3.0		4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 10 A		9FS		7.9		S
DYNAMIC CHARACTERISTICS					-	•	
Input Capacitance			C _{iss}		1425		pF
Output Capacitance	$V_{DS} = 25 \text{ V, } V_{GS} = 0 \text{ V,}$ $f = 1.0 \text{ MHz}$		C _{oss}		150		
Reverse Transfer Capacitance			C _{rss}		35		
Total Gate Charge			Q_g		47		nC
Gate-to-Source Charge	V _{DD} = 310 V, I _D = 10 A	λ,	Q _{gs}		9.3		
Gate-to-Drain ("Miller") Charge	$V_{GS} = 10 \text{ V}$		Q_{gd}		25		
Plateau Voltage			V_{gp}		6.4		V
Gate Resistance			R_g		1.5		Ω
RESISTIVE SWITCHING CHARACTERI	STICS						
Turn-On Delay Time			t _{d(on)}		15		ns
Rise Time	$V_{DD} = 310 \text{ V}, I_D = 10 \text{ A}$		t _r		31		
Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_G = 5 \Omega$		t _{d(off)}		40		
Fall Time			t _f		21		
SOURCE-DRAIN DIODE CHARACTER	ISTICS (T _C = 25°C unless other	erwise not	ed)				
Diode Forward Voltage	I _S = 10 A, V _{GS} = 0 V		V_{SD}			1.6	V
Reverse Recovery Time	$V_{GS} = 0 \text{ V}, V_{DD} = 30 \text{ V}$ $I_S = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		t _{rr}		395		ns
Reverse Recovery Charge			Q _{rr}		3.0		μС

^{4.} Insertion mounted
5. Pulse Width ≤ 380 μs, Duty Cycle ≤ 2%.

TYPICAL CHARACTERISTICS





V_{GS}, GATE-10-SOUNCE VOLTAGE (V)

Figure 2. Transfer Characteristics

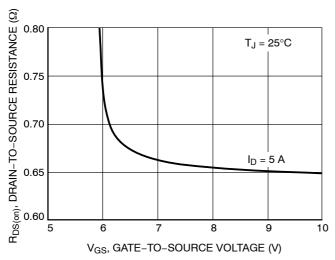


Figure 3. On-Resistance vs. Gate Voltage

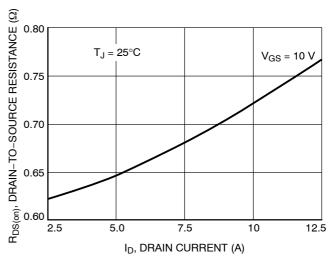


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

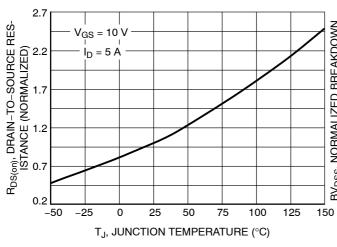


Figure 5. On–Resistance Variation with Temperature

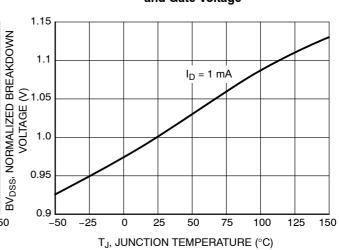


Figure 6. BVDSS Variation with Temperature

TYPICAL CHARACTERISTICS

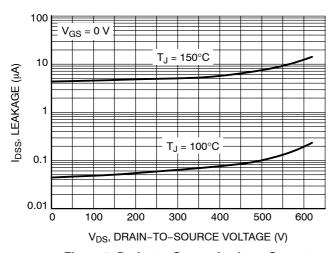


Figure 7. Drain-to-Source Leakage Current vs. Voltage

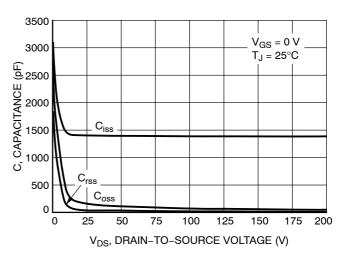


Figure 8. Capacitance Variation

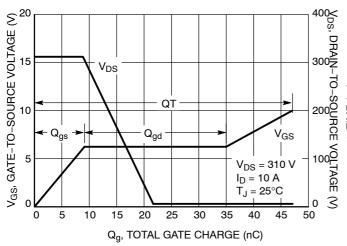


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

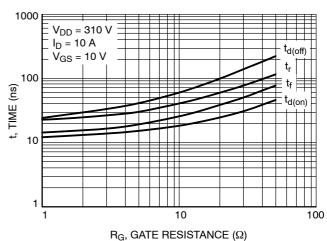


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

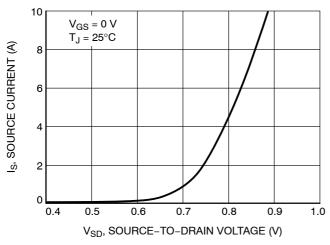


Figure 11. Diode Source Current vs. Forward Voltage

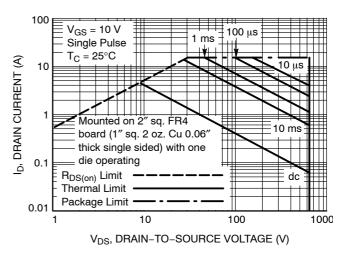


Figure 12. Maximum Rated Forward Biased Safe Operating Area for NDF10N62Z

TYPICAL CHARACTERISTICS

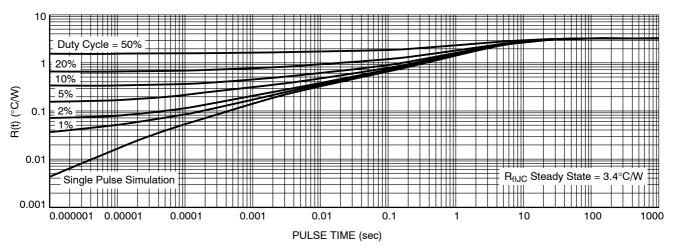


Figure 13. Thermal Impedance for NDF10N62Z

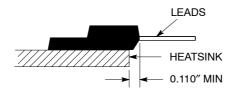


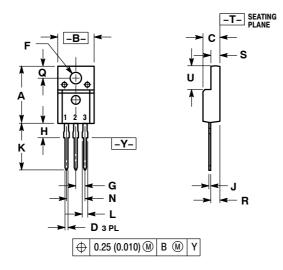
Figure 14. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

^{*}For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

TO-220FP CASE 221D-03 **ISSUE K**



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH
- 221D-01 THRU 221D-02 OBSOLETE, NEW STANDARD 221D-03

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.617	0.635	15.67	16.12
В	0.392	0.419	9.96	10.63
С	0.177	0.193	4.50	4.90
D	0.024	0.039	0.60	1.00
F	0.116	0.129	2.95	3.28
G	0.100	0.100 BSC		BSC
Н	0.118	0.135	3.00	3.43
J	0.018	0.025	0.45	0.63
K	0.503	0.541	12.78	13.73
L	0.048	0.058	1.23	1.47
N	0.200 BSC		5.08 BSC	
Q	0.122	0.138	3.10	3.50
R	0.099	0.117	2.51	2.96
S	0.092	0.113	2.34	2.87
U	0.239	0.271	6.06	6.88

PIN 1. GATE 2. DRAIN

3. SOURCE

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